

<b>Notice of References Cited</b>	Application/Control No. 10/619,446	Applicant(s)/Patent Under Reexamination MALEVILLE, CHRISTOPHE	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0224482	11-2004	Kub et al.	438/458
	B	US-2004/0035525	02-2004	Yokokawa et al.	156/281
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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